

# SuperSOT4<sup>™</sup> DUAL 40V PNP SILICON LOW SATURATION SWITCHING TRANSISTOR

### **SUMMARY**

 $V_{ceo} = -40V$ ;  $R_{sat} = 75m\Omega$ ;  $I_c = -2A$ 

#### DESCRIPTION

This new 4th generation ultra low saturation transistor utilises the Zetex matrix structure combined with advanced assembly techniques to give extremely low on state losses. This makes it ideal for high efficiency, low voltage switching applications.

### MSOP8

#### **FEATURES**

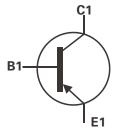
- · Extremely Low Equivalent On Resistance
- Extremely Low Saturation Voltage
- h<sub>FF</sub> characterised up to 5A
- I<sub>C</sub>=2A Continuous Collector Current
- MSOP8 package

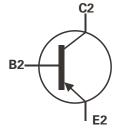
### **APPLICATIONS**

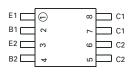
- DC DC Converters
- Power Management Functions
- · Power switches
- Motor control

## ORDERING INFORMATION

DEVICE	REEL SIZE (inches)	TAPE WIDTH (mm)	QUANTITY PER REEL
ZXT12P40DXTA	7	12mm embossed	1000 units
ZXT12P40DXTC	13	12mm embossed	4000 units







Top View

### **DEVICE MARKING**

T12P40DX

### **ABSOLUTE MAXIMUM RATINGS.**

PARAMETER	SYMBOL	LIMIT	UNIT
Collector-Base Voltage	V <sub>CBO</sub>	-50	V
Collector-Emitter Voltage	V <sub>CEO</sub>	-40	V
Emitter-Base Voltage	V <sub>EBO</sub>	-7.5	V
Peak Pulse Current	I <sub>CM</sub>	-5	А
Continuous Collector Current	I <sub>C</sub>	-2	А
Base Current	I <sub>B</sub>	-500	mA
Power Dissipation at TA=25°C (a)(d) Linear Derating Factor	P <sub>D</sub>	0.87 6.9	W mW/°C
Power Dissipation at TA=25°C (a)(e) Linear Derating Factor	P <sub>D</sub>	1.04 8.3	W mW/°C
Power Dissipation at TA=25°C (b)(d) Linear Derating Factor	P <sub>D</sub>	1.25 10	W mW/°C
Operating and Storage Temperature Range	T <sub>j</sub> :T <sub>stg</sub>	-55 to +150	°C

### THERMAL RESISTANCE

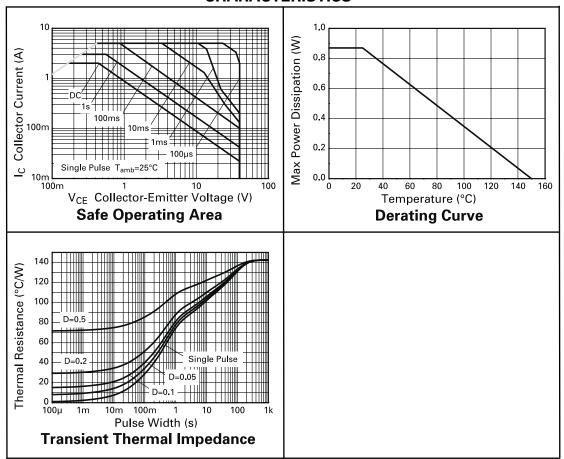
PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(d)	$R_{ heta JA}$	143	°C/W
Junction to Ambient (b)(d)	$R_{\theta JA}$	100	°C/W
Junction to Ambient (a)(e)	$R_{\theta JA}$	120	°C/W

### **NOTES**

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions
- (b) For a device surface mounted on FR4 PCB measured at t≤5 secs.
- (c) Repetitive rating pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.
- (d) For device with one active die.
- (e) For device with two active die running at equal power.



### **CHARACTERISTICS**





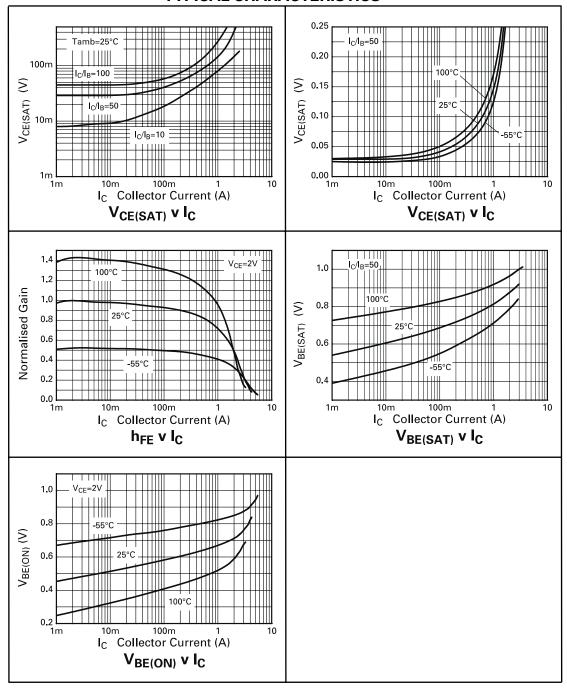
### ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25$ °C unless otherwise stated).

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.	
Collector-Base Breakdown Voltage	V <sub>(BR)CBO</sub>	-50	-95		V	I <sub>C</sub> =-100μA	
Collector-Emitter Breakdown Voltage	V <sub>(BR)CEO</sub>	-40	-80		V	I <sub>C</sub> =-10mA*	
Emitter-Base Breakdown Voltage	V <sub>(BR)EBO</sub>	-7.5	-8.5		V	I <sub>E</sub> =-100μA	
Collector Cut-Off Current	I <sub>CBO</sub>			-100	nA	V <sub>CB</sub> =-40V	
Emitter Cut-Off Current	I <sub>EBO</sub>			-100	nA	V <sub>EB</sub> =-6V	
Collector Emitter Cut-Off Current	I <sub>CES</sub>			-100	nA	V <sub>CES</sub> =-40V	
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>		-18 -155 -190 -150	-22 -215 -260 -190	mV mV mV	I <sub>C</sub> =-0.1A, I <sub>B</sub> =-10mA* I <sub>C</sub> =-1A, I <sub>B</sub> =-20mA* I <sub>C</sub> =-2A, I <sub>B</sub> =-100mA* I <sub>C</sub> =-2A, I <sub>B</sub> =-200mA*	
Base-Emitter Saturation Voltage	V <sub>BE(sat)</sub>		-0.92	-1.0	V	I <sub>C</sub> =-2A, I <sub>B</sub> =-100mA*	
Base-Emitter Turn-On Voltage	V <sub>BE(on)</sub>		-0.80	-0.85	V	I <sub>C</sub> =-2A, V <sub>CE</sub> =-2V*	
Static Forward Current Transfer Ratio	h <sub>FE</sub>	300 300 150 10	450 450 300 25	900		I <sub>C</sub> =-10mA, V <sub>CE</sub> =-2V* I <sub>C</sub> =-1A, V <sub>CE</sub> =-2V* I <sub>C</sub> =-2A, V <sub>CE</sub> =-2V* I <sub>C</sub> =-5A, V <sub>CE</sub> =-2V*	
Transition Frequency	f <sub>T</sub>		130		MHz	I <sub>C</sub> =-30mA, V <sub>CE</sub> =-10V f=-50MHz	
Output Capacitance	C <sub>obo</sub>		35		pF	V <sub>CB</sub> =-10V, f=1MHz	
Turn-On Time	t <sub>(on)</sub>		97		ns	V <sub>CC</sub> =-10V, I <sub>C</sub> =-1A I <sub>B1</sub> =I <sub>B2</sub> =-20mA	
Turn-Off Time	t <sub>(off)</sub>		640		ns		

<sup>\*</sup>Measured under pulsed conditions. Pulse width=300 $\mu$ s. Duty cycle  $\leq 2\%$ 

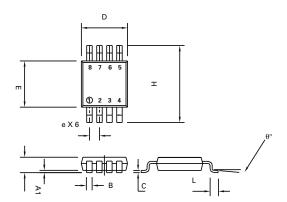


### **TYPICAL CHARACTERISTICS**





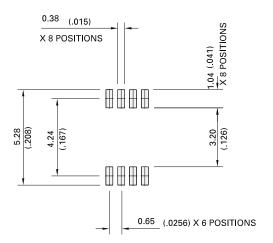
### **PACKAGE DIMENSIONS**



Conforms to JEDEC MO-187 Iss A

DIM	Millimetres		Inches	
	MIN	MAX	MIN	MAX
А		1.10		0.043
A1	0.05	0.15	0.002	0.006
В	0.25	0.40	0.010	0.016
С	0.13	0.23	0.005	0.009
D	2.90	3.10	0.114	0.122
е	0.65	BSC	0.0256	BSC
E	2.90	3.10	0.114	0.122
Н	4.90	BSC	0.193	BSC
L	0.40	0.70	0.016	0.028
q°	0°	6°	0°	6°

### PAD LAYOUT DETAILS



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